

**Notice of References Cited**

Application/Control No.

10/667,694

Applicant(s)/Patent Under  
Reexamination  
VANDENTOP ET AL.

Examiner

Tuan T. Dinh

Art Unit

2841

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,454,161	10-1995	Beilin et al.	29/852
*	B	US-5,813,115	09-1998	Misawa et al.	29/832
*	C	US-6,084,781	07-2000	Klein, Dean A.	361/771
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.